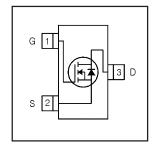
# International Rectifier

# IRLML2502PbF

#### HEXFET® Power MOSFET



- N-Channel MOSFET
- SOT-23 Footprint
- Low Profile (<1.1mm)</li>
- Available in Tape and Reel
- Fast Switching
- Lead-Free
- Halogen-Free



# $V_{DSS} = 20V$ $R_{DS(on)} = 0.045\Omega$

#### Description

These N-Channel MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET® power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in battery and load management.

A thermally enhanced large pad leadframe has been incorporated into the standard SOT-23 package to produce a HEXFET Power MOSFET with the industry's smallest footprint. This package, dubbed the Micro3™, is ideal for applications where printed circuit board space is at a premium. The low profile (<1.1mm) of the Micro3 allows it to fit easily into extremely thin application environments such as portable electronics and PCMCIA cards. The thermal resistance and power dissipation are the best available.



#### **Absolute Maximum Ratings**

	Parameter	Max.	Units
V <sub>DS</sub>	Drain- Source Voltage	20	V
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 4.5V	4.2	
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 4.5V	3.4	A
I <sub>DM</sub>	Pulsed Drain Current ①	33	
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation	1.25	W
P <sub>D</sub> @T <sub>A</sub> = 70°C	Power Dissipation	0.8	VV
	Linear Derating Factor	0.01	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 12	V
T <sub>J,</sub> T <sub>STG</sub>	Junction and Storage Temperature Range	-55 to + 150	°C

#### **Thermal Resistance**

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient®	75	100	°C/W

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### Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	20			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.01		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		0.035	0.045	Ω	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 4.2A ②
			0.050	0.080		V <sub>GS</sub> = 2.5V, I <sub>D</sub> = 3.6A ②
V <sub>GS(th)</sub>	Gate Threshold Voltage	0.60		1.2	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
g <sub>fs</sub>	Forward Transconductance	5.8			S	$V_{DS} = 10V, I_D = 4.0A$
1	Drain-to-Source Leakage Current			1.0	μA	$V_{DS} = 16V, V_{GS} = 0V$
I <sub>DSS</sub>	Diali-to-Source Leakage Current			25		$V_{DS} = 16V, V_{GS} = 0V, T_{J} = 70^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			-100	nA	V <sub>GS</sub> = -12V
	Gate-to-Source Reverse Leakage			100	11/	V <sub>GS</sub> = 12V
Qg	Total Gate Charge		8.0	12		$I_D = 4.0A$
Q <sub>gs</sub>	Gate-to-Source Charge		1.8	2.7	nC	$V_{DS} = 10V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		1.7	2.6		V <sub>GS</sub> = 5.0V ②
t <sub>d(on)</sub>	Turn-On Delay Time		7.5			$V_{DD} = 10V$
t <sub>r</sub>	Rise Time		10		ns	$I_D = 1.0A$
t <sub>d(off)</sub>	Turn-Off Delay Time		54		115	$R_G = 6\Omega$
t <sub>f</sub>	Fall Time		26			$R_D = 10\Omega$ ②
C <sub>iss</sub>	Input Capacitance		740			$V_{GS} = 0V$
Coss	Output Capacitance		90		pF	$V_{DS} = 15V$
C <sub>rss</sub>	Reverse Transfer Capacitance		66			f = 1.0MHz

#### **Source-Drain Ratings and Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions							
Is	Continuous Source Current			1.3		MOSFET symbol							
	(Body Diode)			- 1.3	A	showing the							
I <sub>SM</sub>	Pulsed Source Current			33	33	33	33	33	33	33	33	] ^	integral reverse
	(Body Diode) ①				33	p-n junction diode.							
$V_{SD}$	Diode Forward Voltage			1.2	V	$T_J = 25^{\circ}C$ , $I_S = 1.3A$ , $V_{GS} = 0V$ ②							
t <sub>rr</sub>	Reverse Recovery Time		16	24	ns	$T_J = 25^{\circ}C, I_F = 1.3A$							
Q <sub>rr</sub>	Reverse Recovery Charge		8.6	13	nC	di/dt = 100A/μs ②							

#### Notes:

- $\ensuremath{\mathbb{O}}$  Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ② Pulse width  $\leq$  300 $\mu$ s; duty cycle  $\leq$  2%.

# International TOR Rectifier

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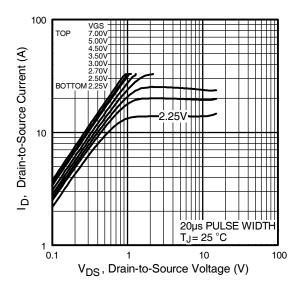


Fig 1. Typical Output Characteristics

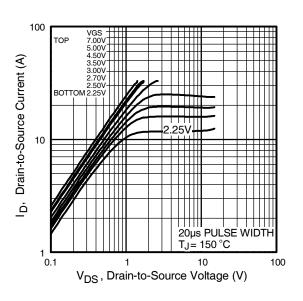


Fig 2. Typical Output Characteristics

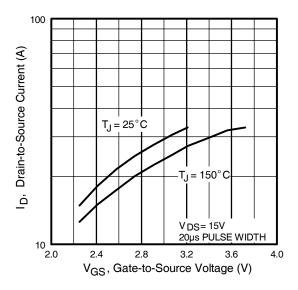
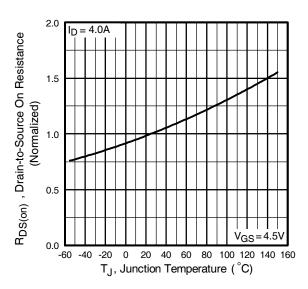
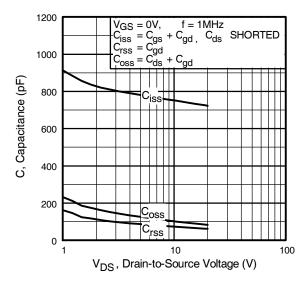


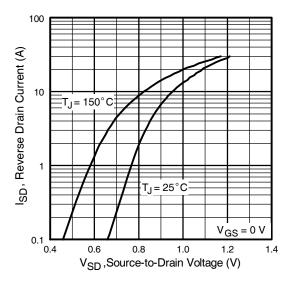
Fig 3. Typical Transfer Characteristics



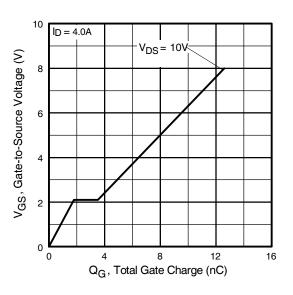
**Fig 4.** Normalized On-Resistance Vs. Temperature



**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 7.** Typical Source-Drain Diode Forward Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage

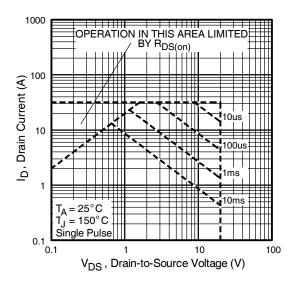
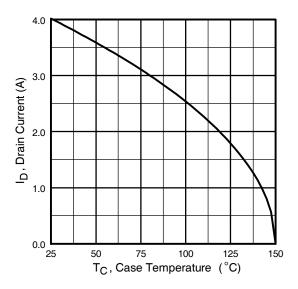


Fig 8. Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current Vs. Case Temperature

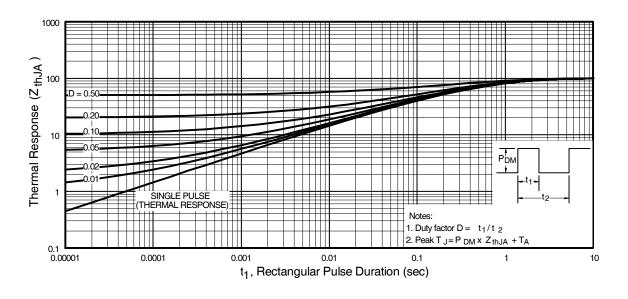


Fig 10. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

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International **IOR** Rectifier

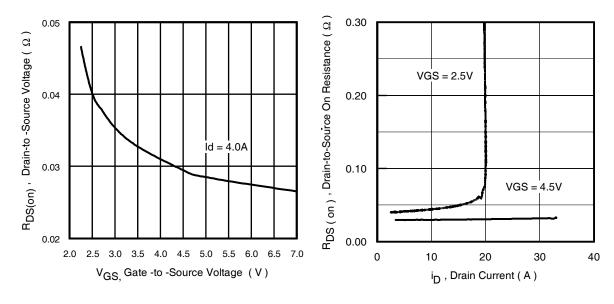


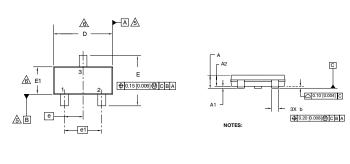
Fig 11. On-Resistance Vs. Gate Voltage

Fig 12. On-Resistance Vs. Drain Current

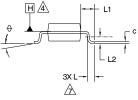
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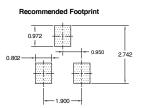
## Micro3 (SOT-23) Package Outline

Dimensions are shown in millimeters (inches)



DIMENSIONS						
SYMBOL	MILLIM	ETERS	INCHES			
	MIN	MAX	MIN	MAX		
Α	0.89	1.12	0.035	0.044		
A1	0.01	0.10	0.0004	0.004		
A2	0.88	1.02	0.035	0.040		
b	0.30	0.50	0.012	0.020		
С	0.08	0.20	0.003	0.008		
D	2.80	3.04	0.110	0.120		
Е	2.10	2.64	0.083	0.104		
E1	1.20	1.40	0.047	0.055		
е	0.95	BSC	0.037	BSC		
e1	1.90	BSC	0.075 BSC			
L	0.40	0.60	0.016	0.024		
L1	0.54	REF	0.021	REF		
L2	0.25	BSC	0.010	BSC		
0	0	8	0	8		





- I. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1994 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]. 3. CONTROLLING DIMENSION: MILLIMETER.
- A DATUM PLANE H IS LOCATED AT THE MOLD PARTING LINE.
- A\_BATUM PLANE HIS LOCATED AT THE MICLD PARTING LINE.

  A\_DATUM A AND B TO BE DETERMINED AT DATUM PLANE H.

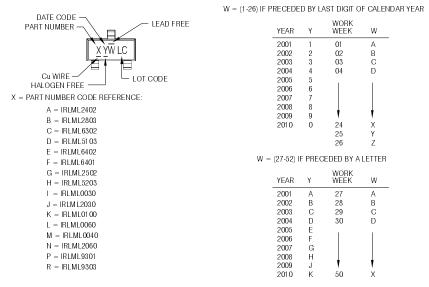
  A\_DIMENSIONS D AND ET ARE MEASURED AT DATUM PLANE H. DIMENSIONS DOES
  NOT INCLUDE MOLD PROTRUSIONS OR INTERE LAD PLASH MOLD PROTRUSIONS
  OR INTERLEAD PLASH SHALL NOT EXCEED 0.25 MM [0.010 INCH] PER SIDE.

  A\_DIMENSION, IS THE LEAD LEWISH POR SOLDEPING TO A SUBSTRATE.

  8. OUTLINE CONFORMS TO JEDEC OUTLINE TO 228 AB.

# Micro3 (SOT-23/TO-236AB) Part Marking Information

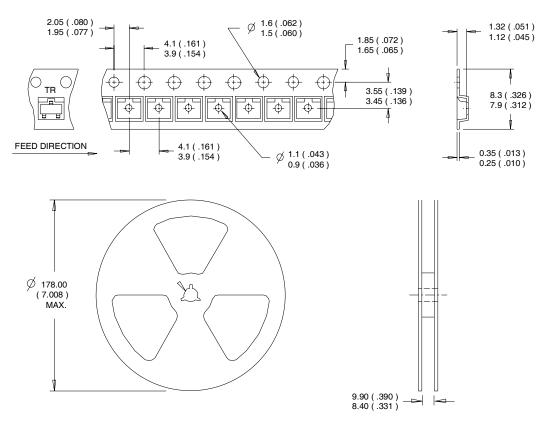
Notes: This part marking information applies to devices produced after 02/26/2001



Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/ www.irf.com

## Micro3™ Tape & Reel Information

Dimensions are shown in millimeters (inches)



#### NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice.



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